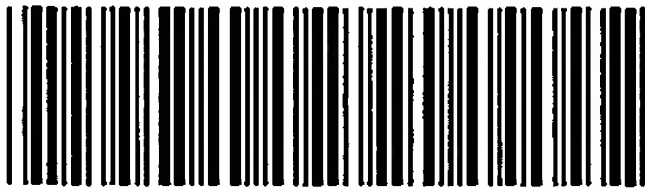


<div>Search Notes</div> <div></div>	Application No.	Applicant(s)	
	10/621,522	OHNISHI, NORIAKI	
	Examiner	Art Unit	
	(Nancy) Thanh-Nhan P Nguyen	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	123	2/17/2005	TN
428	1.21	2/18/2005	TN
<i>A</i>			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<hr/>	<i>as above</i>	<i>2/18/05</i>	<i>TN</i>
<i>NPL Search: www.sid.org/proc year 2000, 2001, 2002</i>		<i>2/18/05</i>	<i>TN</i>

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
ohnishi.in. ohnishi.in. and 349/\$.ccls. 349/123.ccls. and inorganic; 349/123.ccls. and crystalline;	2/17/2005	TN
inorganic adj (align\$ orient\$); crystalline adj2 conductive; (inorganic adj (align\$ orient\$)) same ((indium adj tin) ITO)	2/17/2005	TN
(X-ray adj diffraction) and 349/\$.ccls. (crystalline adj2 ITO);	2/18/2005	TN
(crystalline adj2 conductive) and (inorganic adj (align\$ orient\$)); 428/1.21.ccls.	2/18/2005	TN